Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY DOCKET NO. 245837US2		SERIAL NO. 10/717,566
		APPLICANT Herman P. GODFRIED, et al.		
LIST OF REFERENCES CITED BY APPLICANT		FILING DATE November 21, 2003		GROUP 1793

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AF						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
/SH/	AJ	JP 7-277890	10/24/1995	Japan (English translation only)		
	AK	JP 6-263418	09/20/1994	Japan (with English abstract) (corresponds to EP 0 615 954 A1)		
	AL	EP 0 615 954 A1	09/21/1994	Europe (corresponds to JP 6-263418)		
	AM	JP 1-131014	05/23/1989	Japan (with English abstract) (corresponds to EP 0 316 856 A1)		
	AN	EP 0 316 856 A1	05/24/1989	Europe (corresponds to JP 1-131014)		
	AO	JP 9-165295	06/24/1997	Japan (with English abstract) (corresponds to EP 0 715 885 A2)		
	AP	EP 0 715 885 A2	06/12/1996	Europe (corresponds to JP 9-165295)		
	AO	JP 6-107454	04/19/1994	Japan (with English abstract) (corresponds to EP 0 589 464 A1)		
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	AS	JP 11-1392	01/06/1999	Japan (English translation only)		

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

/SH/	AT	P. KANIA, et al., Diamond and Related Materials, Vol. 4, pp. 425-428 (1995)
	AU	English translation of "Characterization of thick homoepitaxial film on diamond (001) substrate II"
	AV	English translation of "Homoepitaxial growth of diamond (001) with nitrogen doping"
	AW	J. MICHLER, et al., J. Appl. Phys., Vol. 83, No. 1, pp. 187-197 (1998)
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	AZ	P.E. PEHRSSON, et al., Mat. Res. Soc. Symp, Proc., Vol. 416, pp. 51-56 (1996)

☐ Additional References sheet(s) attached

Examiner /Stuart Hendrickson/ (05/16/2008)	Date Considered

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.